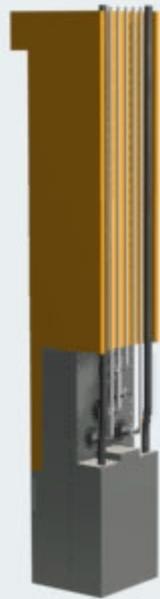


# Luminosity Monitor Status



From LBNL

John Byrd

Bill Turner

Peter Denes

Massimo Placidi

Alex Ratti

Stefano De Santis

Jean-Francois Beche

Jim Greer

Marco Monroy

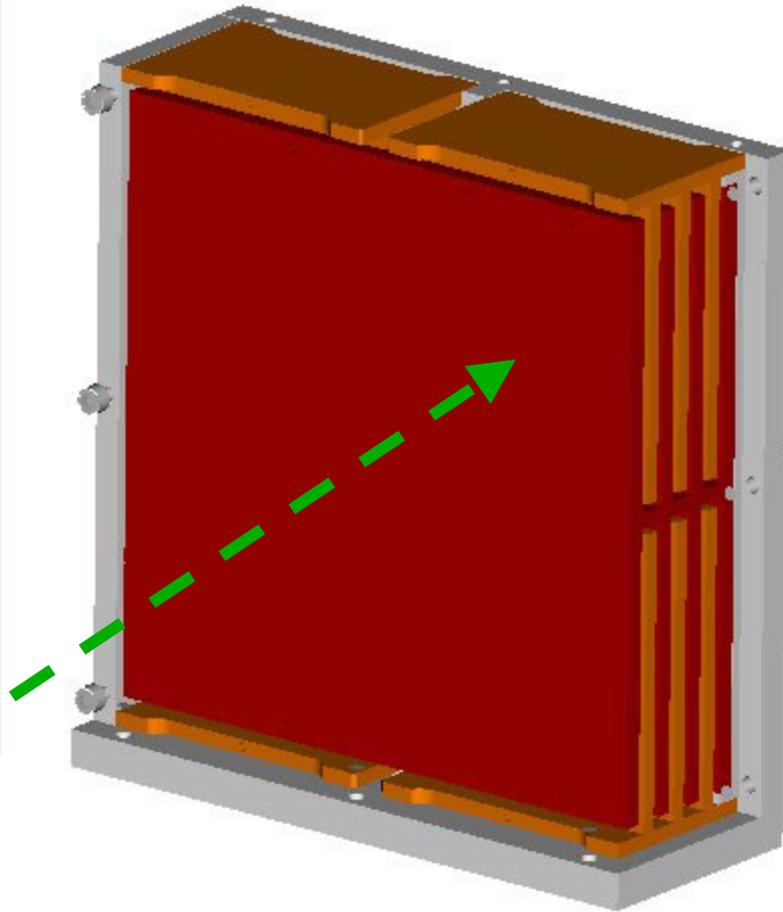
Max Zolotarev

Mostly concerning  
Ionization chamber  
Some CdTe as well

# Ionization Chamber

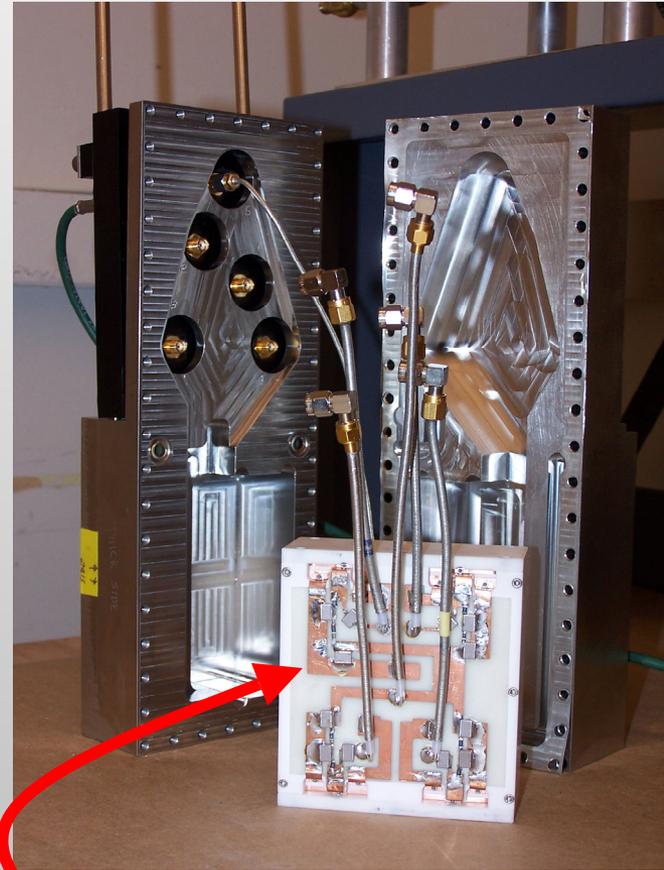
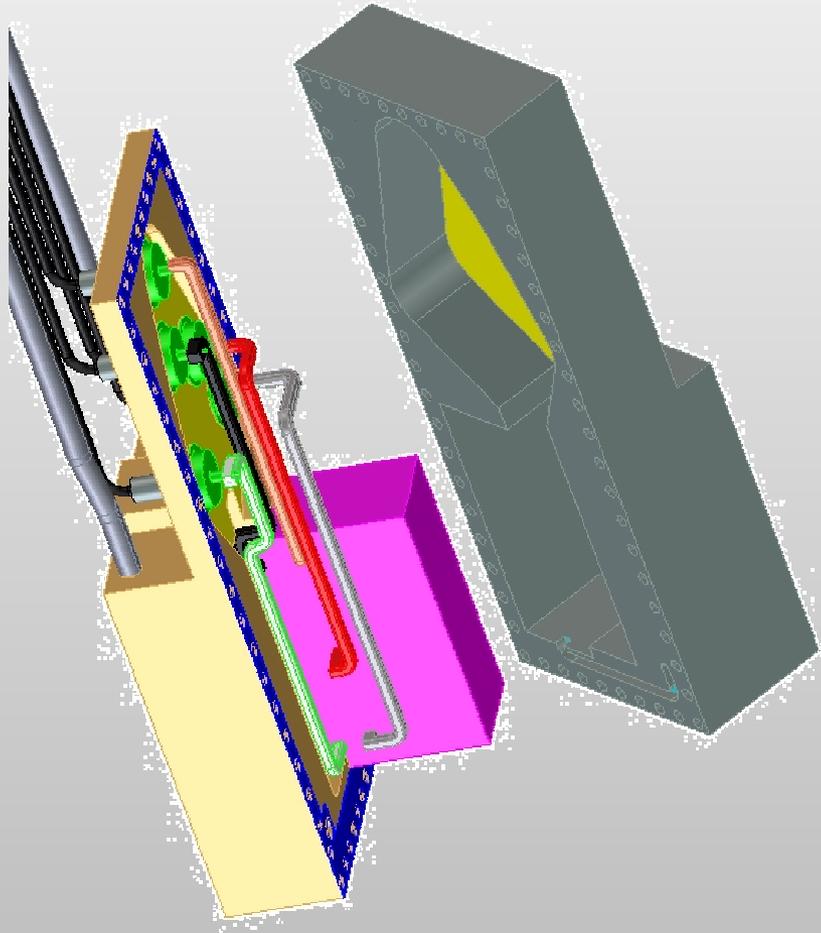
## Reminder

- 4 quadrant gas ionization chamber (4 quadrant electrodes)
- 6x1 mm gaps
- Ar + N<sub>2</sub>
- Central ground structure
- 3m coax between chamber and electronics



Beam

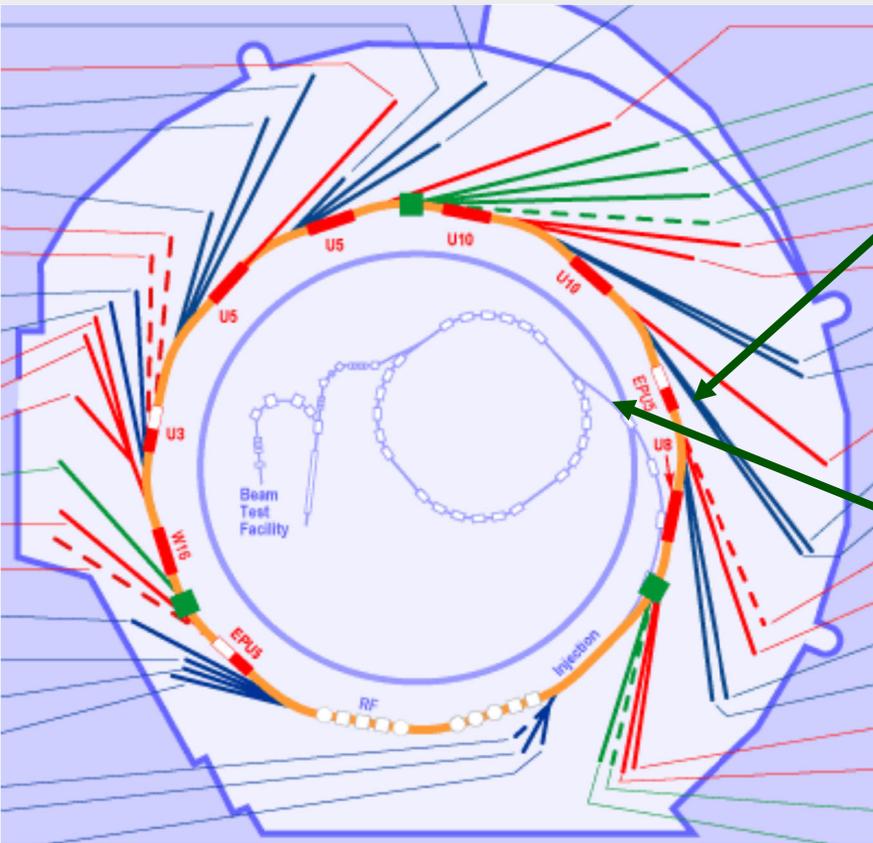
# Detector



Metalized MACOR

- Component attach
- Strain relief

# Beam Tests at the ALS



## Storage Ring spill:

- 1.5 GeV e<sup>-</sup> with variable spacing
- 30 psec pulse length
- intensity of a few e<sup>-</sup>
- weekly access

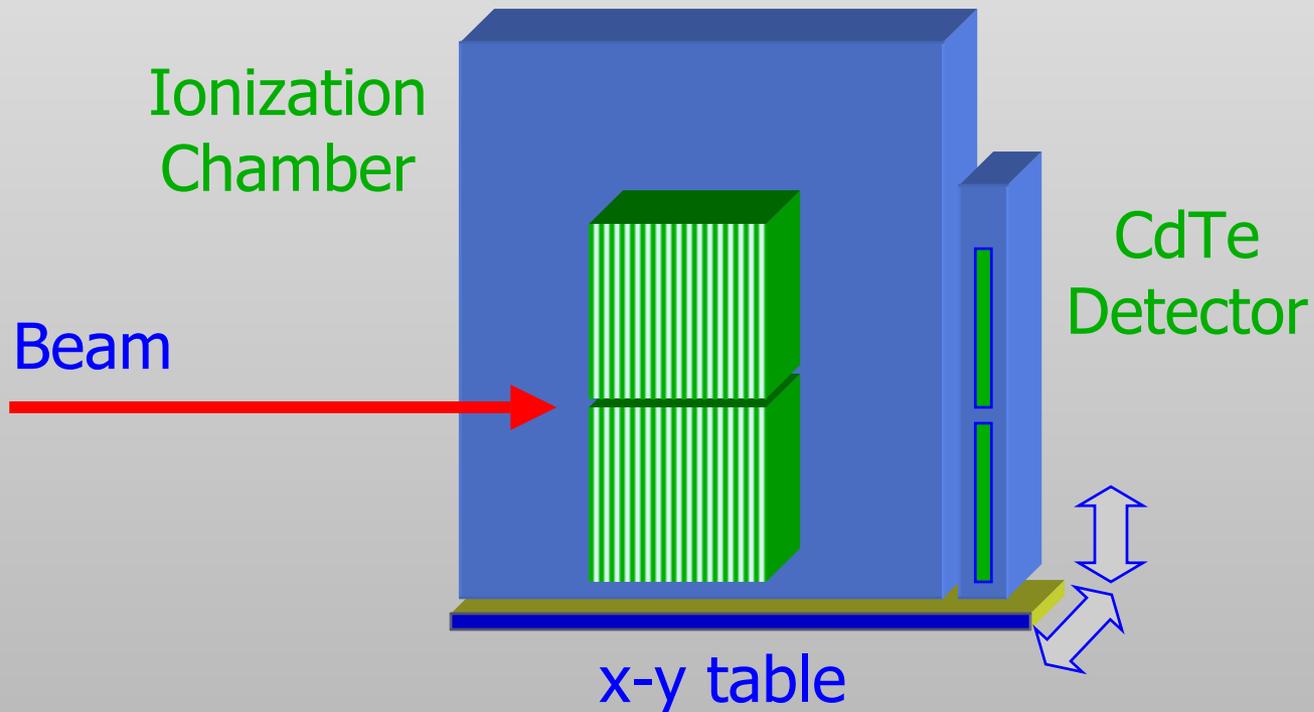
## Booster-To-Storage Ring spur:

- 1.5 GeV e<sup>-</sup> at 1 Hz rate
- 30 psec pulse length
- intensity from 1 to 1e9 e<sup>-</sup> (1e3 typical)
- daily access and availability

BTS: Detailed performance  
Ring: "40 MHz" test

# ALS Booster Tests

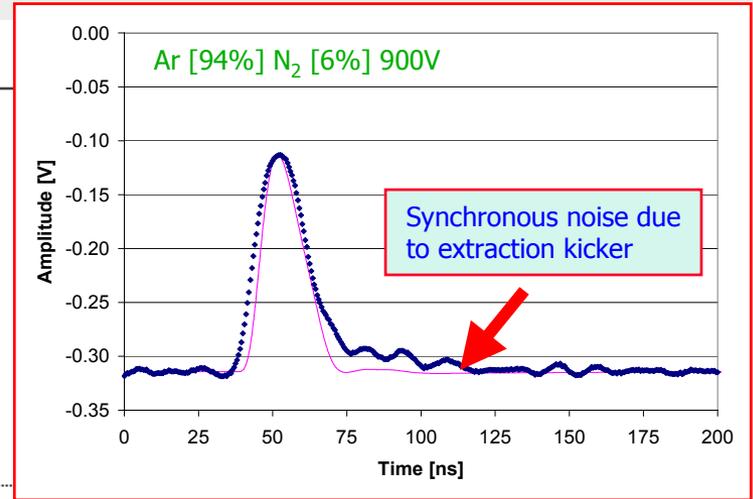
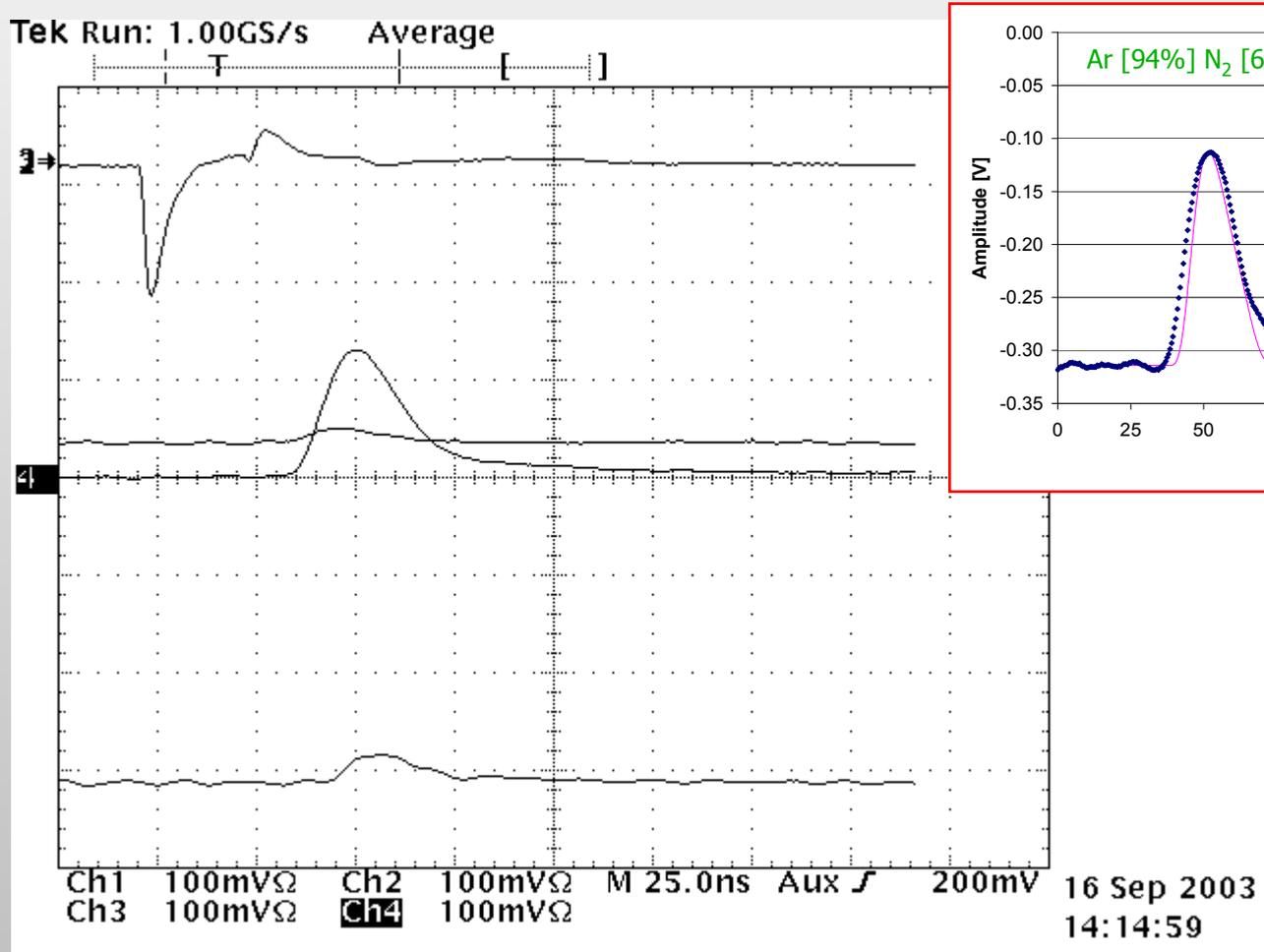
- “ $\delta$ -function”  $e^-$  beam (50 ps); 1.5 GeV; 1 Hz
- Adjustable intensity (typically ran at 20 pp interaction equivalent  $\pm 50\%$ )



# Waveforms at BTS

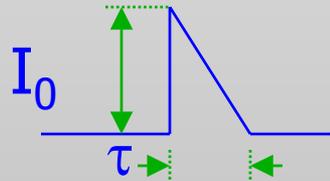
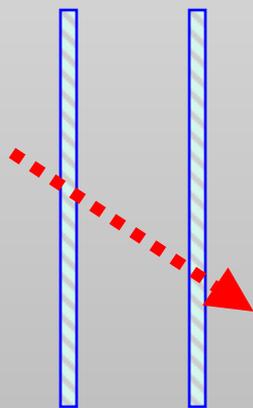
CdTe

Gas Quadrants



# Gas Tests

- Chamber uses Ar (100- $x$  %) + N<sub>2</sub> ( $x$  %)
- Design was based on Monte Carlo calculations of gas properties
- Drift velocity is key parameter (determines speed)



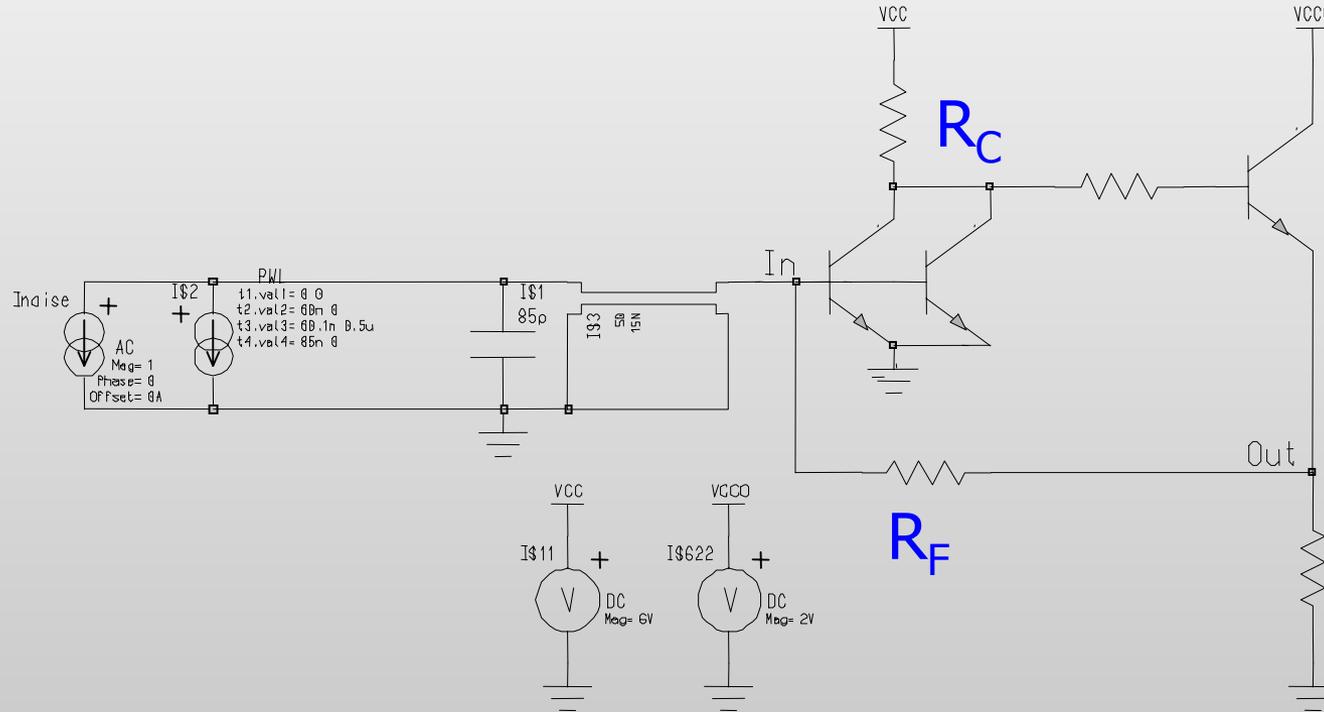
$$\tau = x_{\text{GAP}} / v_D \quad Q = \int_0^{\tau} I(t) dt = \frac{1}{2} I_0 \tau$$

$$\text{charge/proton} = Q_0 \times x_{\text{GAP}} \times P \text{ [Atm]} \times N_{\text{GAP}}$$

$$N_1 \text{ e}^- / \text{MIP/mm} \times N_2 \text{ MIP/p}$$

$$I_0 = 2 Q_0 v_D P N_{\text{GAP}}$$

# Test System Performance with Simple Trans-Resistance Amplifier



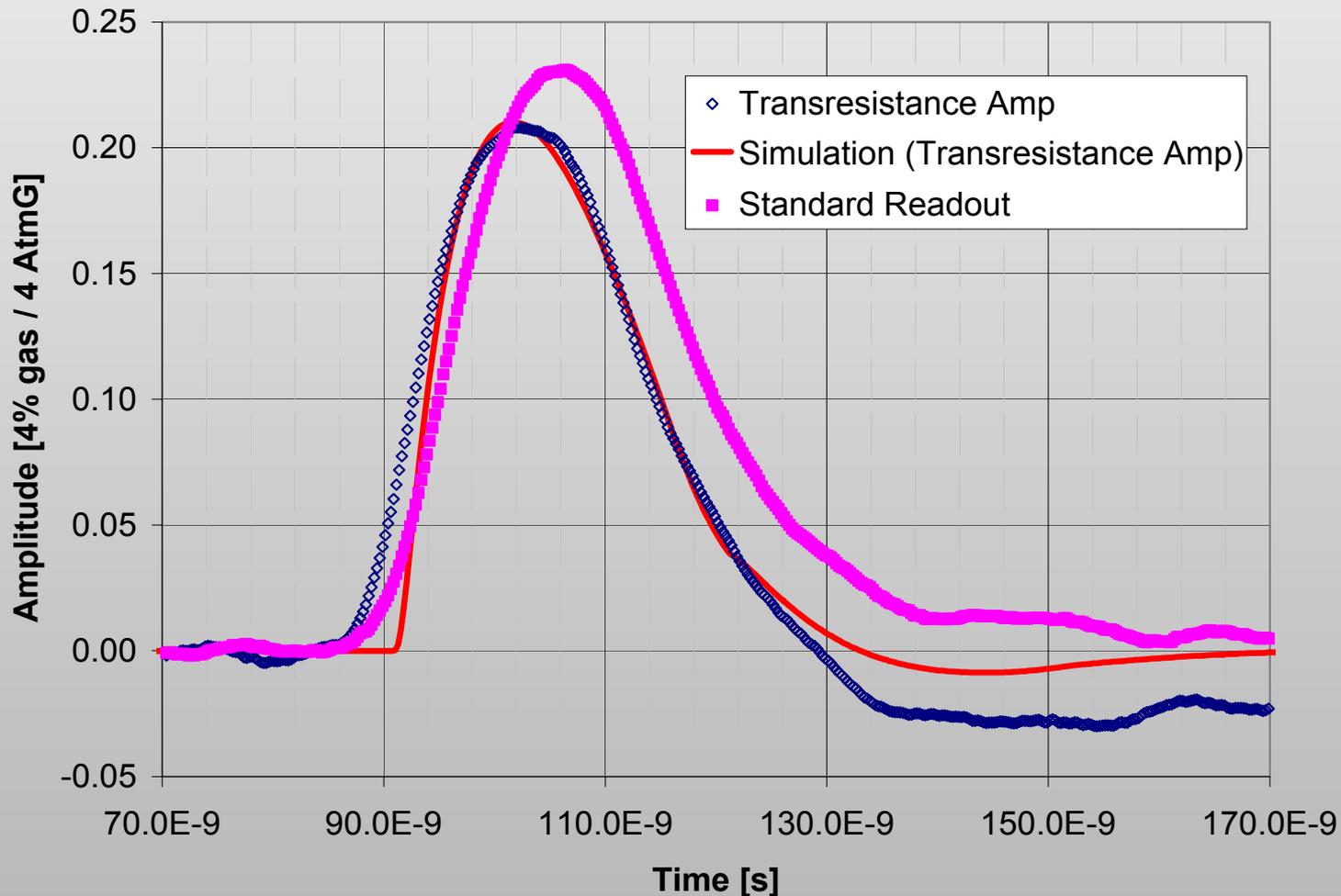
$$Z = R_F / (1 + g_m R_C)$$

$$V_{OUT} = R_F I_{IN}$$

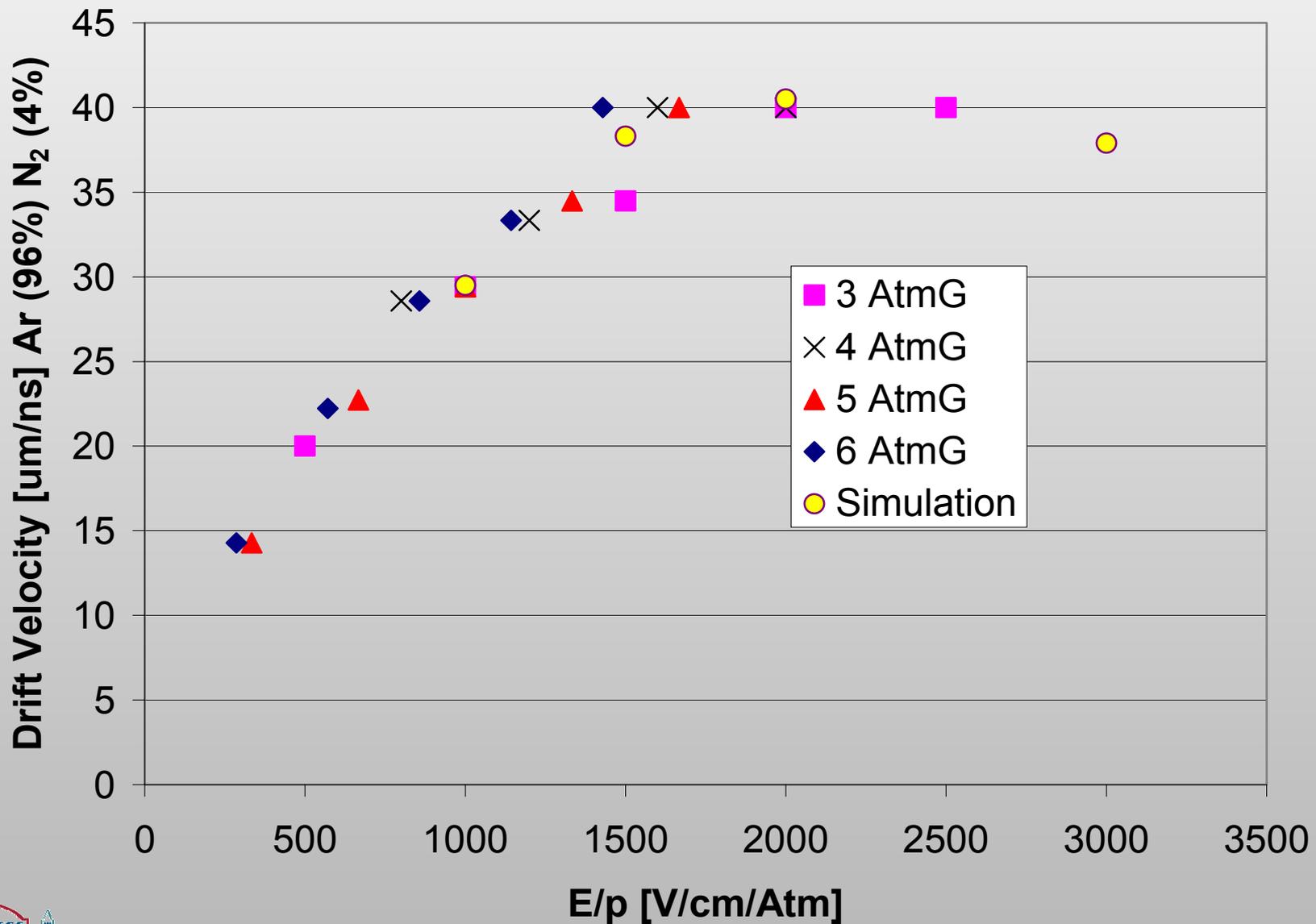
Avoids need to deconvolve shaping

# Modified Electronics for Gas Tests

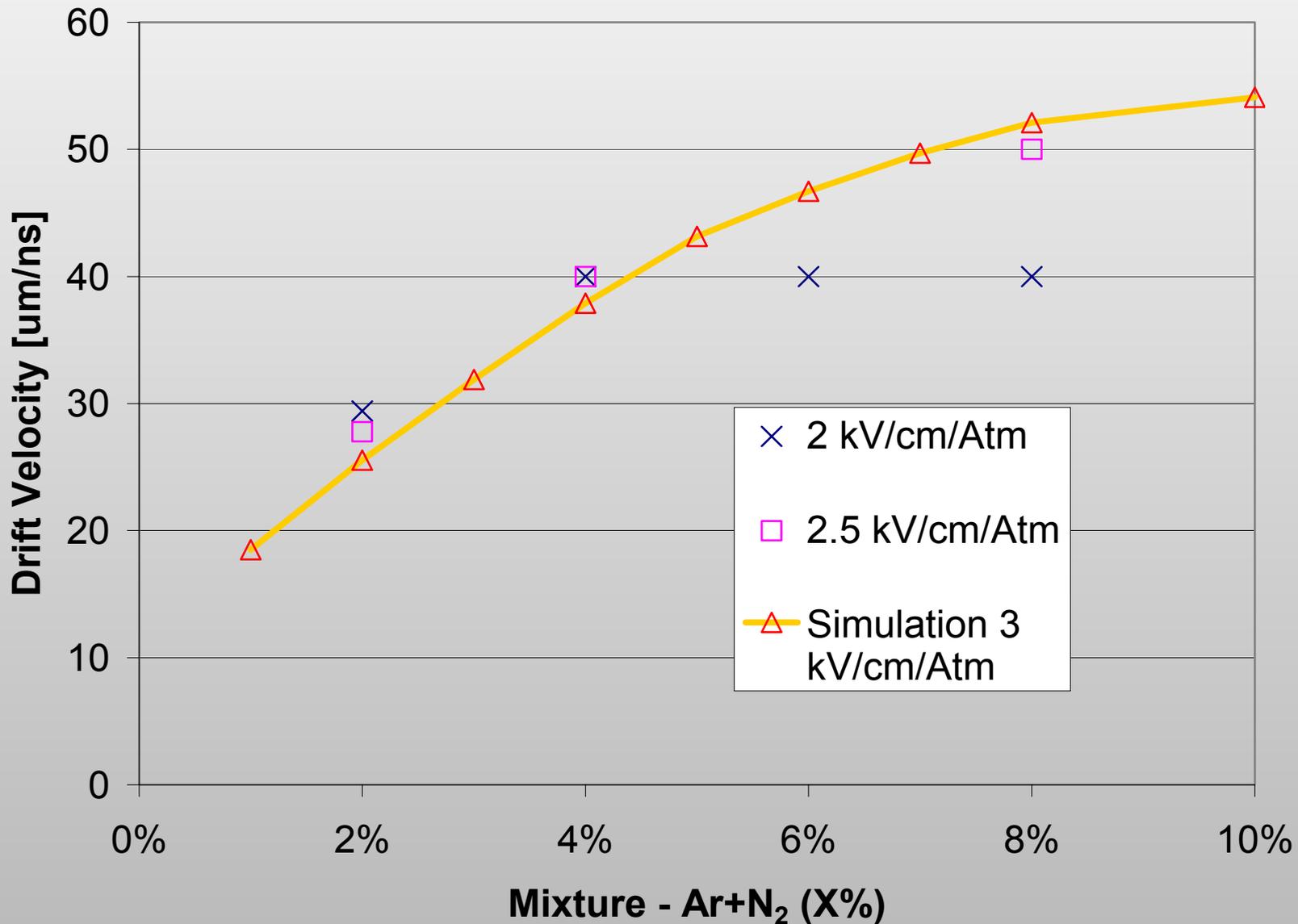
For these tests, use transresistance amp (no shaping)  
Fit measured waveform (P, % N<sub>2</sub>) to simulation with T<sub>D</sub>



# Nominal Mix – vary $V$ , $p$ and measure $v_D$

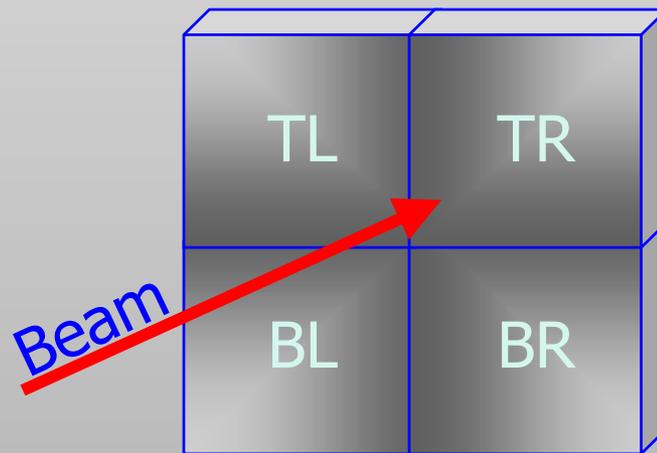


vs.  $N_2$  Content – vary mix and measure  $v_D$



# Position Scans

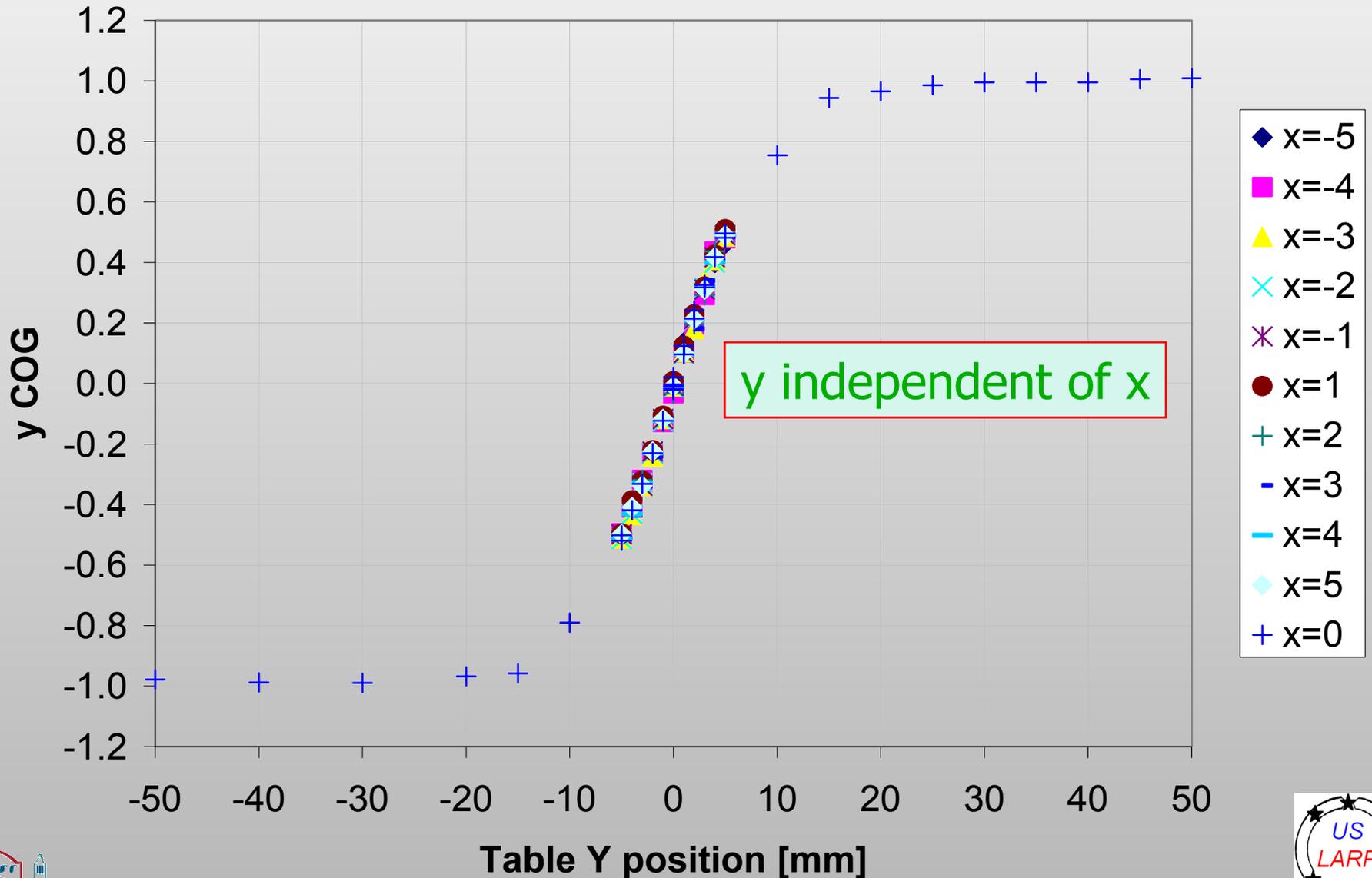
- “Raster scan” e<sup>-</sup> beam across chamber (by moving x-y table with respect to beam)
- Record pulse heights of the 4 quadrants (note: primitive DAQ → relatively large error bars on measurements)
- Measure COG (center-of-gravity) coordinates vs. known table position



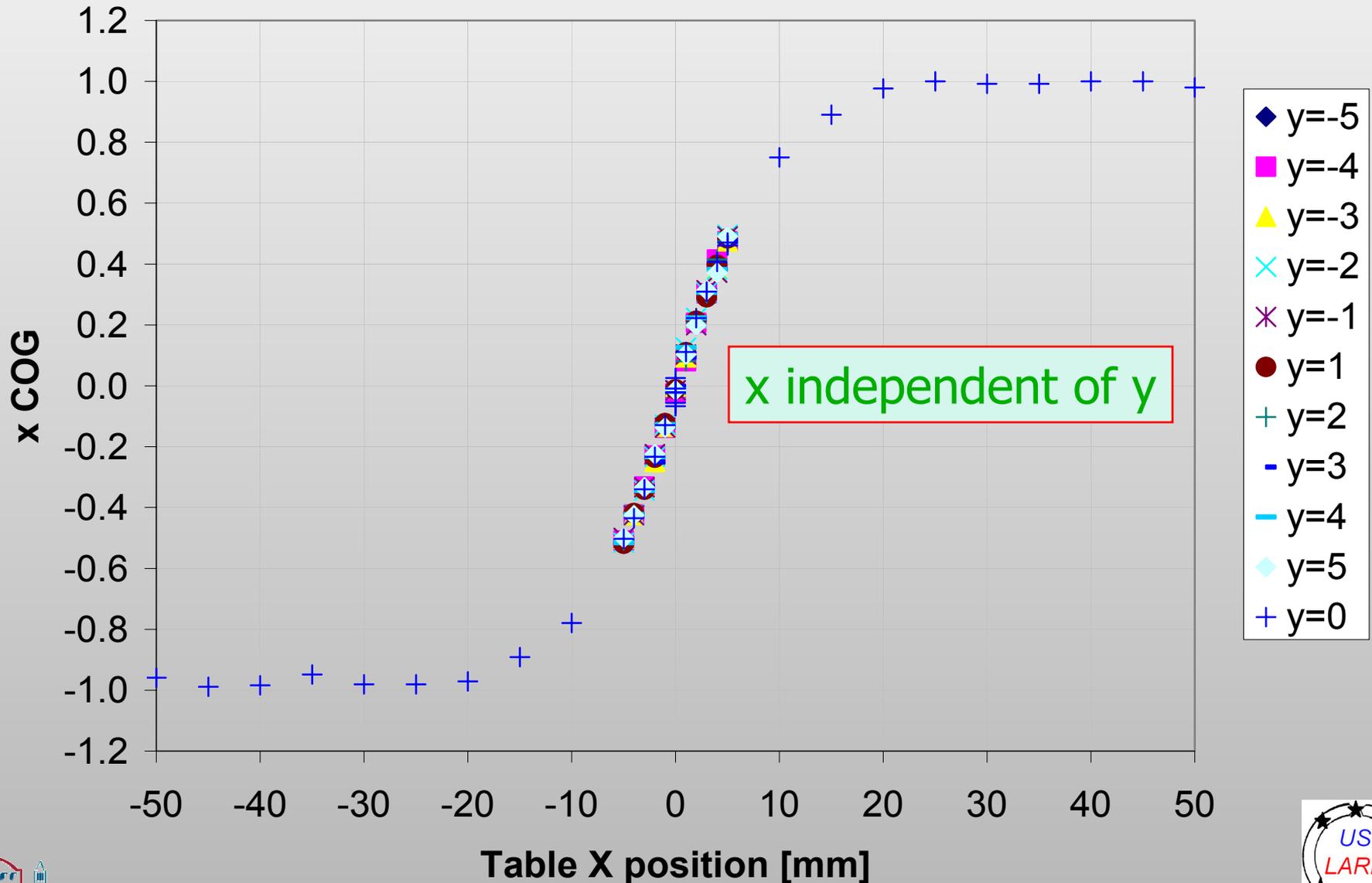
$$x = \frac{(TR + BR) - (TL + BL)}{TR + BR + TL + BL}$$
$$y = \frac{(TR + TL) - (BR + BL)}{TR + BR + TL + BL}$$

# Scan – y Results at Different x

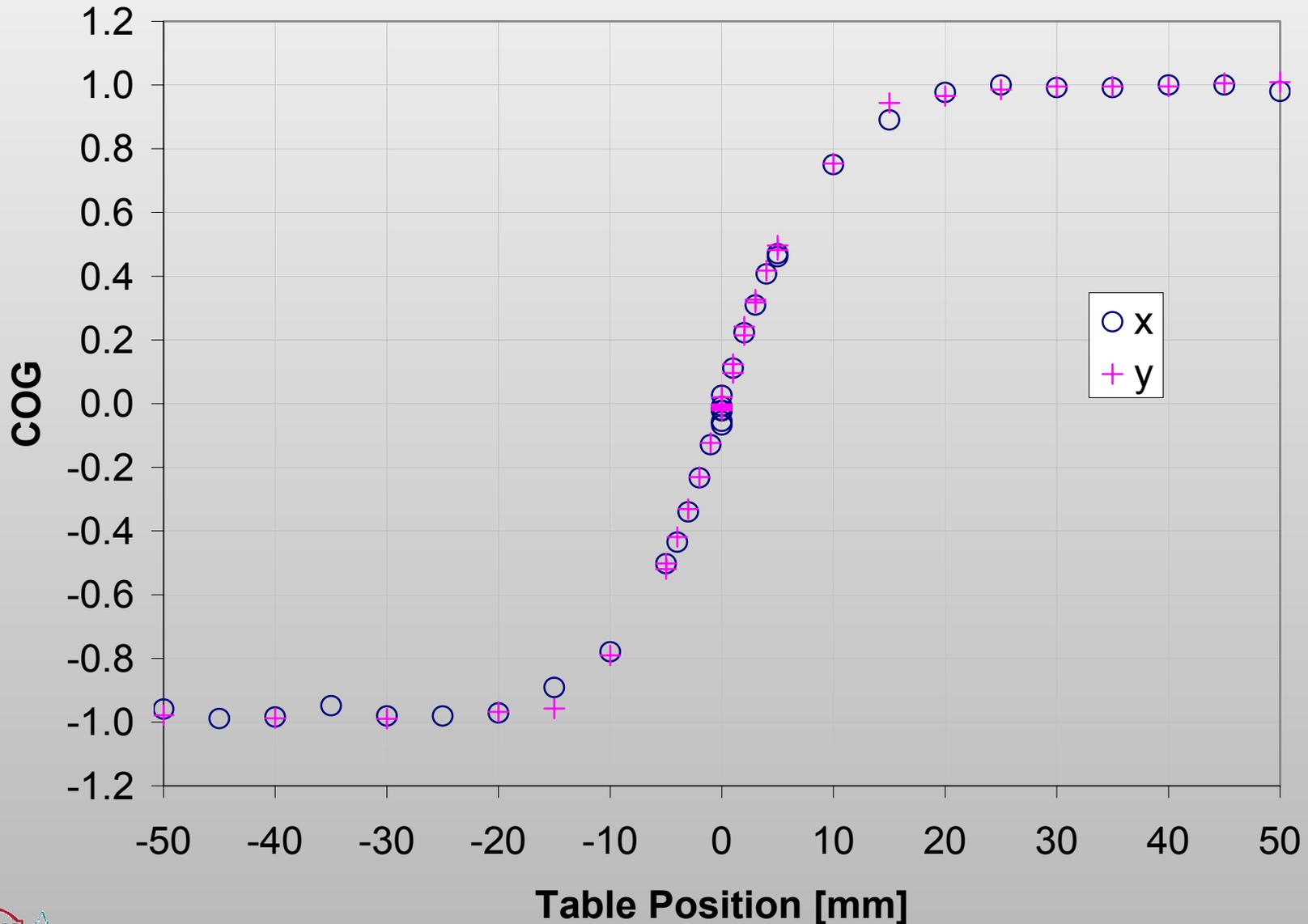
(Narrow beam)



# Scan – x Results at Different y (Narrow beam)

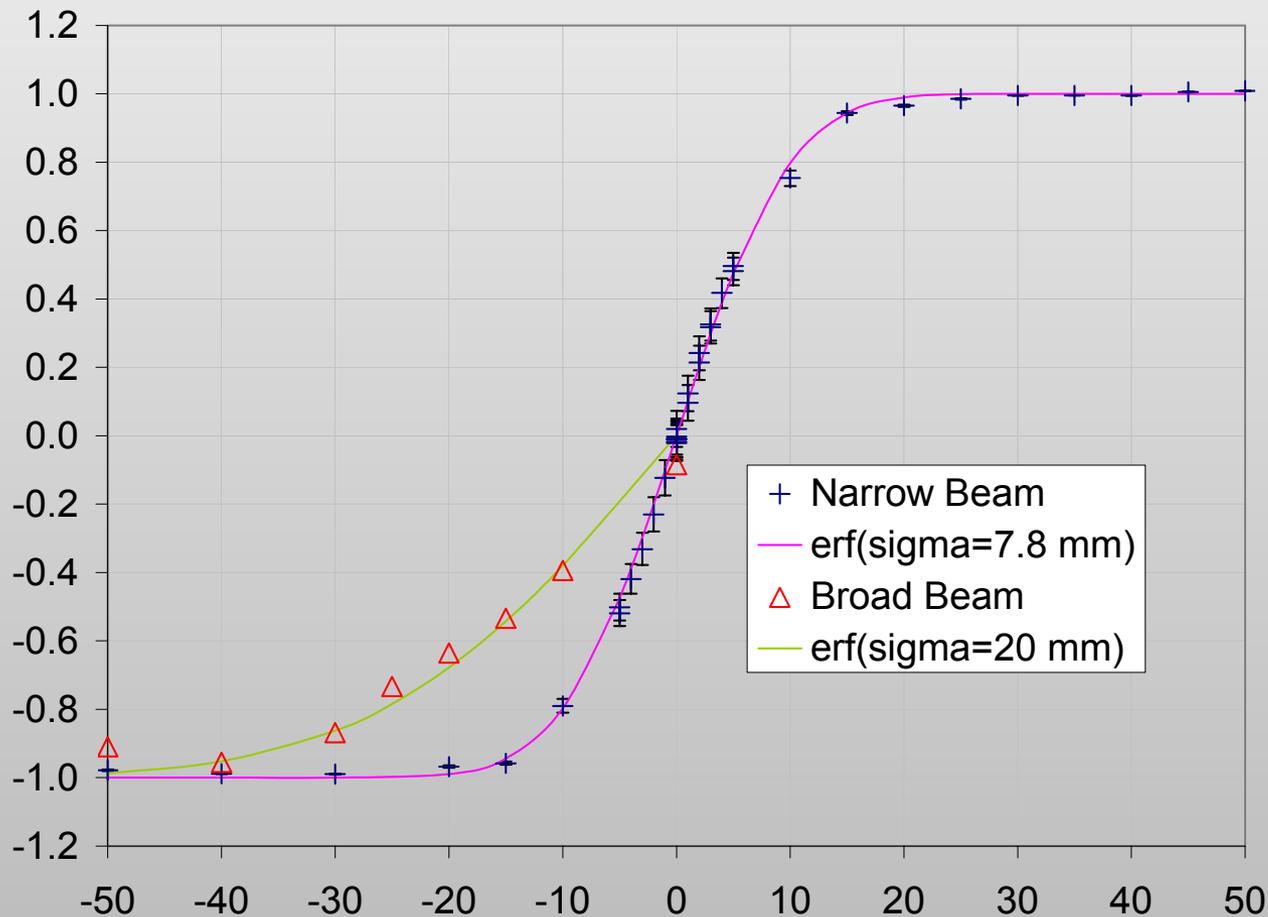


# Symmetric x and y Response



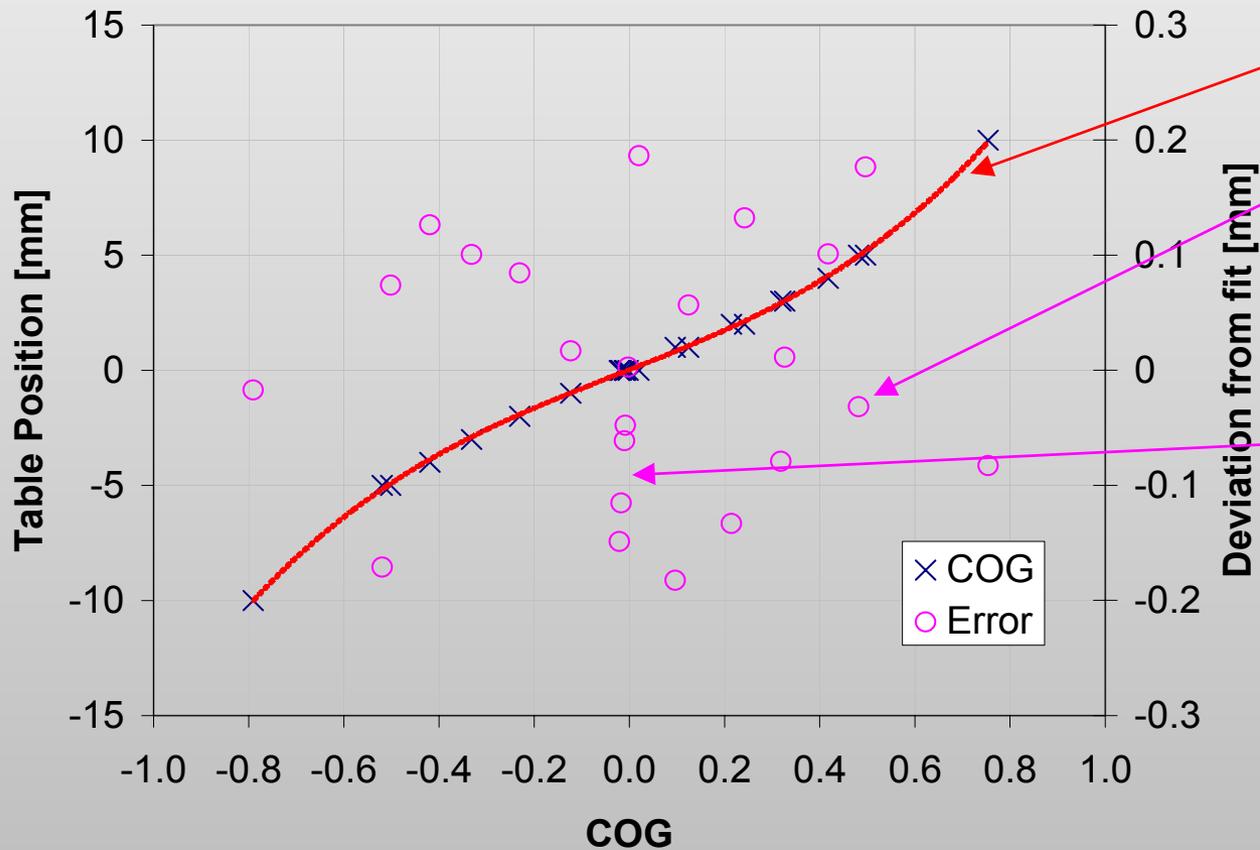
# Beam Size

Most scanning done with narrow beam



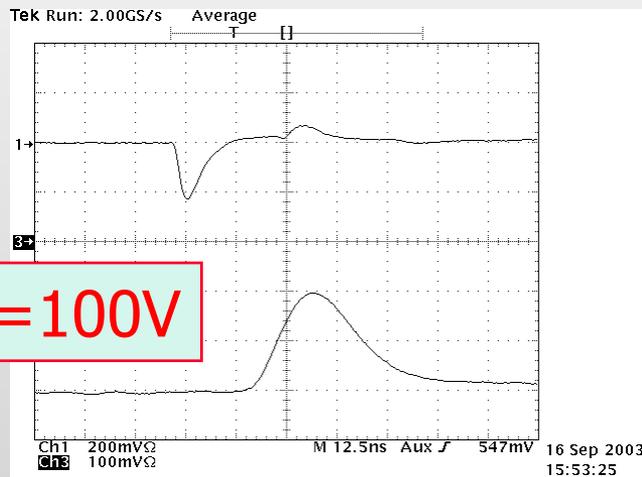
Assume gaussian  
beam profile  $\Rightarrow$   
COG fits to  $erf()$   
 $\Rightarrow$  Narrow beam  
has  $\sigma \sim 8$  mm  
 $\Rightarrow$  Broad beam  
has  $\sigma \sim 20$  mm

# Position Resolution

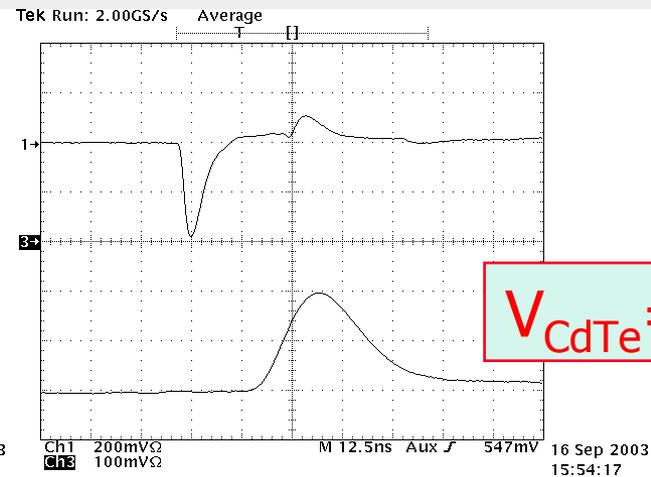


Fit COG vs position to polynomial.  
Error is deviation from fit ( $\sigma \sim 110 \mu\text{m}$ )  
Primitive DAQ: Estimate measurement error from reproducibility ( $\sigma \sim 110 \mu\text{m}$ )  
Resolution is better than current measurement precision

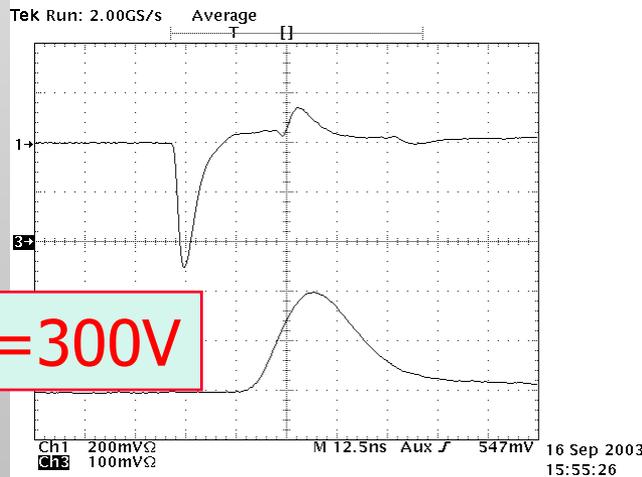
# CdTe Signal vs. Bias Voltage



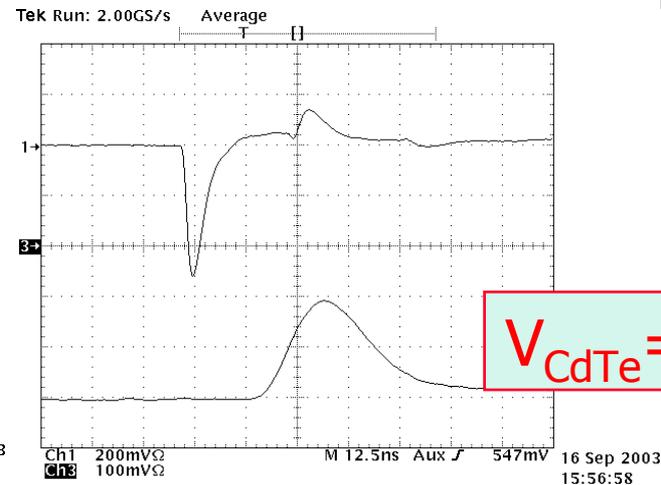
$V_{\text{CdTe}} = 100\text{V}$



$V_{\text{CdTe}} = 200\text{V}$



$V_{\text{CdTe}} = 300\text{V}$

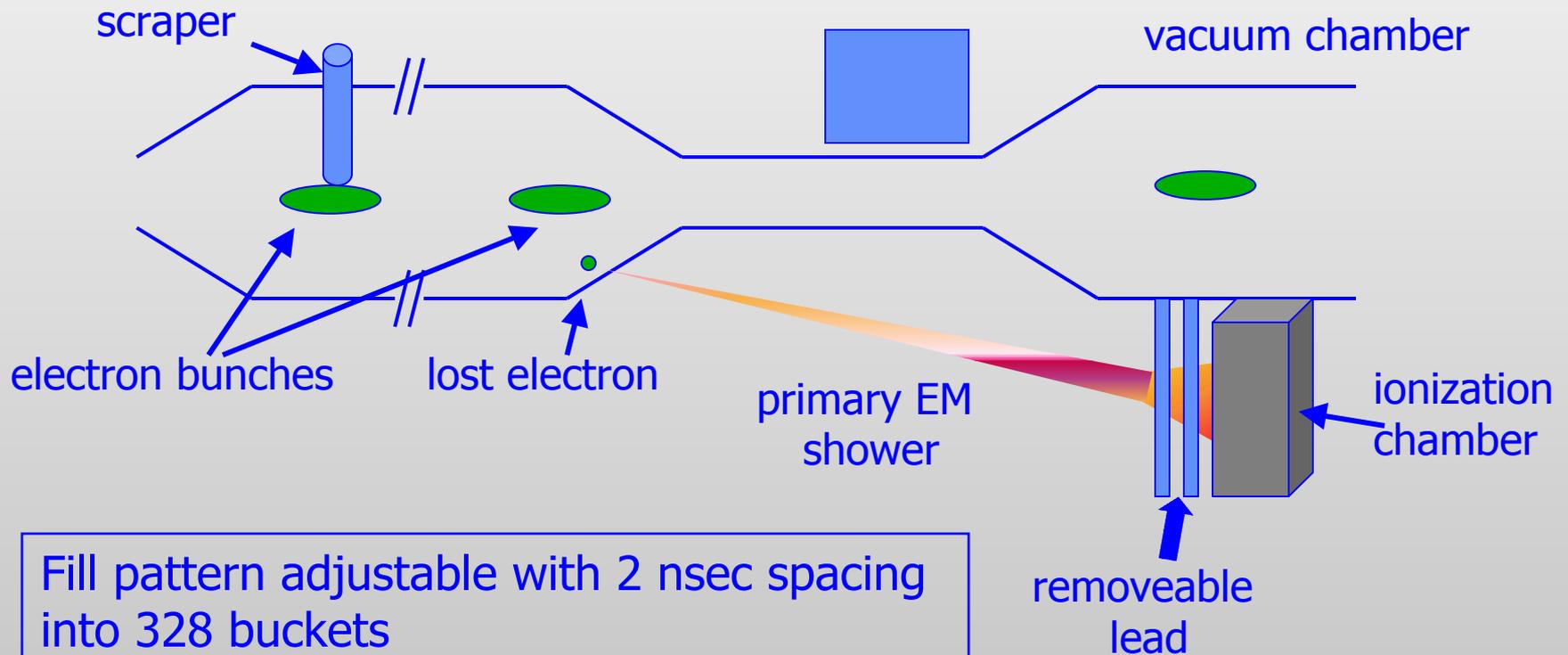


$V_{\text{CdTe}} = 400\text{V}$

# BTS Conclusions

- Simulated performance = measured performance
- Drift velocities of  $> 45 \mu\text{m}/\text{ns}$  (i.e. collection time  $< 25 \text{ ns}$ ) attained (factor of 2 improvement over previous mixture)
- Ionization chamber works as a true 4-quadrant detector (“obvious”, but 1<sup>st</sup> time chamber worked as a 4-quadrant detector)
- $x$  and  $y$  are independent
- Position resolution (across quadrant boundaries) is better than we can currently measure (need to improve our DAQ!) i.e.  $< 110 \mu\text{m}$

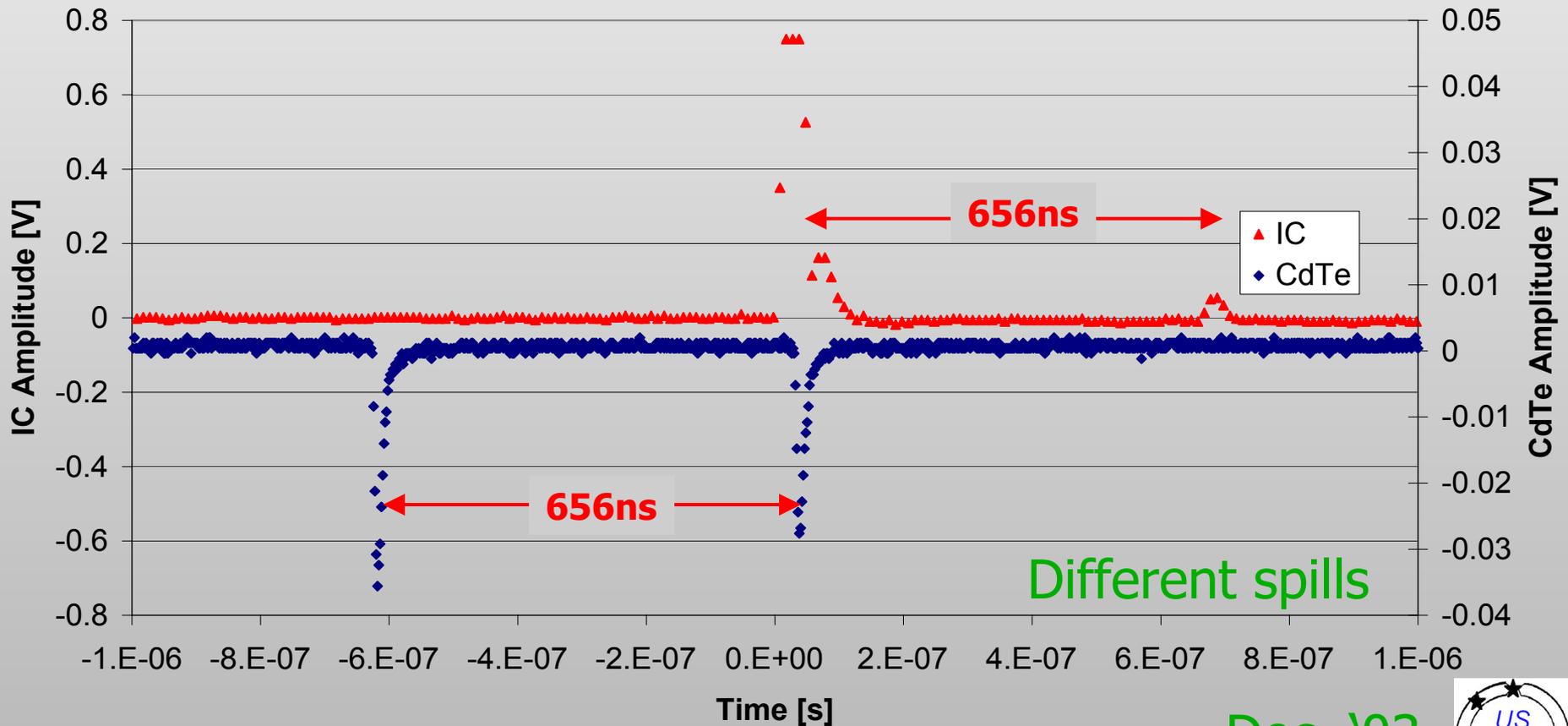
# ALS Ring Tests



Fill pattern adjustable with 2 nsec spacing  
into 328 buckets  
For example:  
24 ns  $\Rightarrow$  41.7 MHz, max 27 bunches  
26 ns  $\Rightarrow$  38.5 MHz, max 25 bunches  
LHC conditions: 25 ns  $\Rightarrow$  40 MHz

# Does it work?

- Fill pattern = 1 bunch

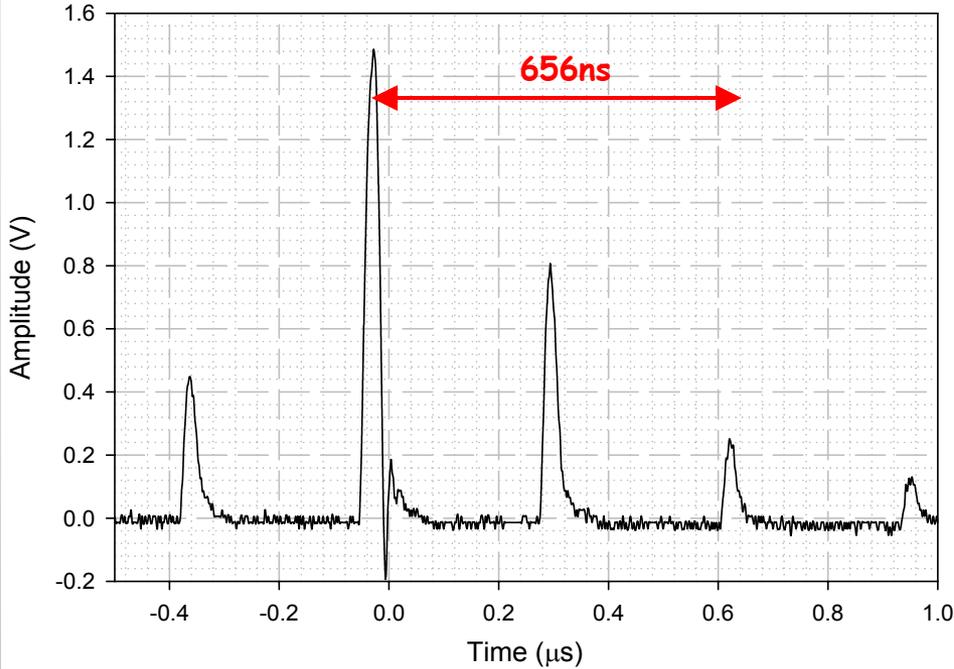


Dec. '03



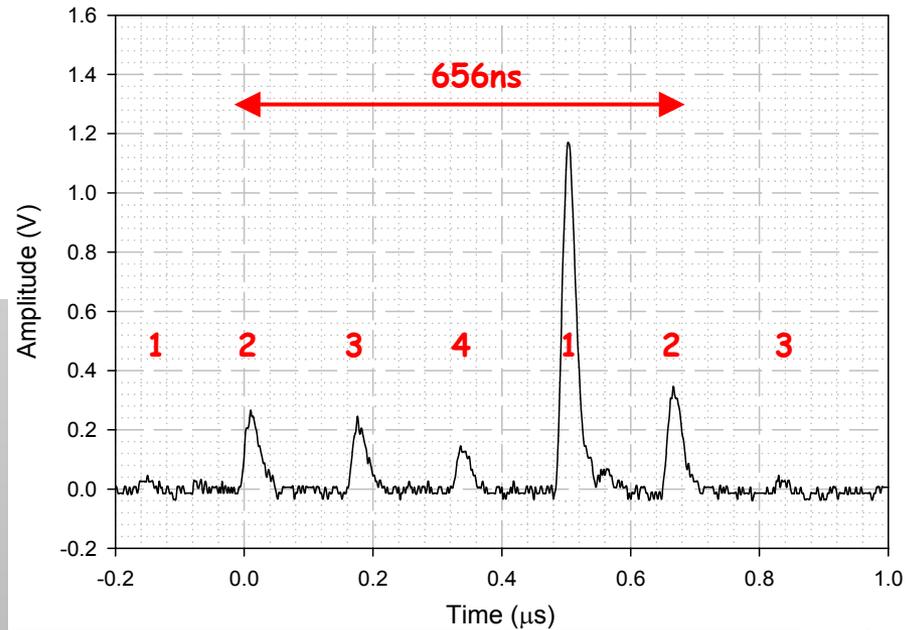
# Increase the Number of Bunches

Quadrant 3 - 4% Mixture - 2.5 atm - HV = 500V



2 bunches

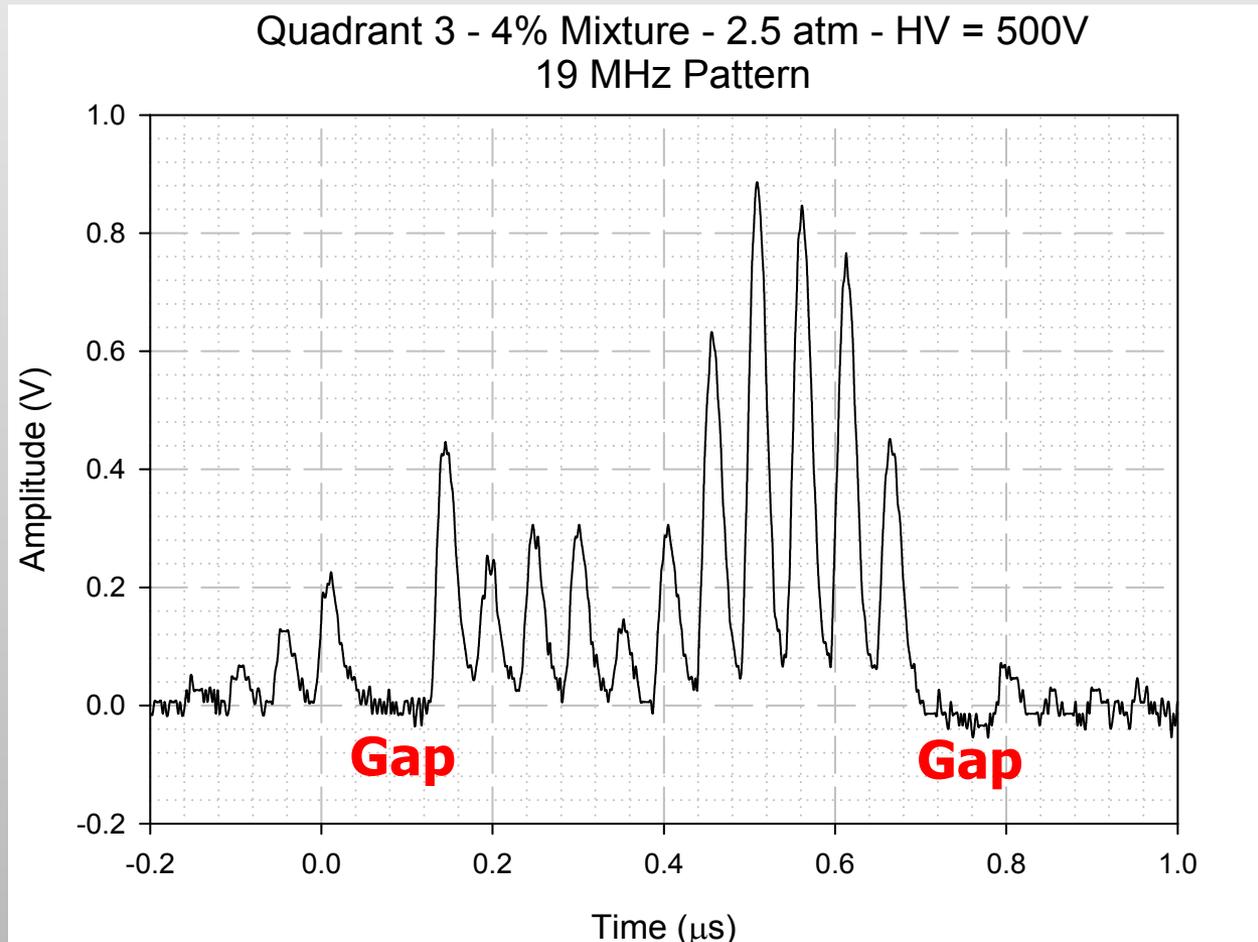
Quadrant 3 - 4% Mixture - 2.5 atm - HV = 500V



4 bunches

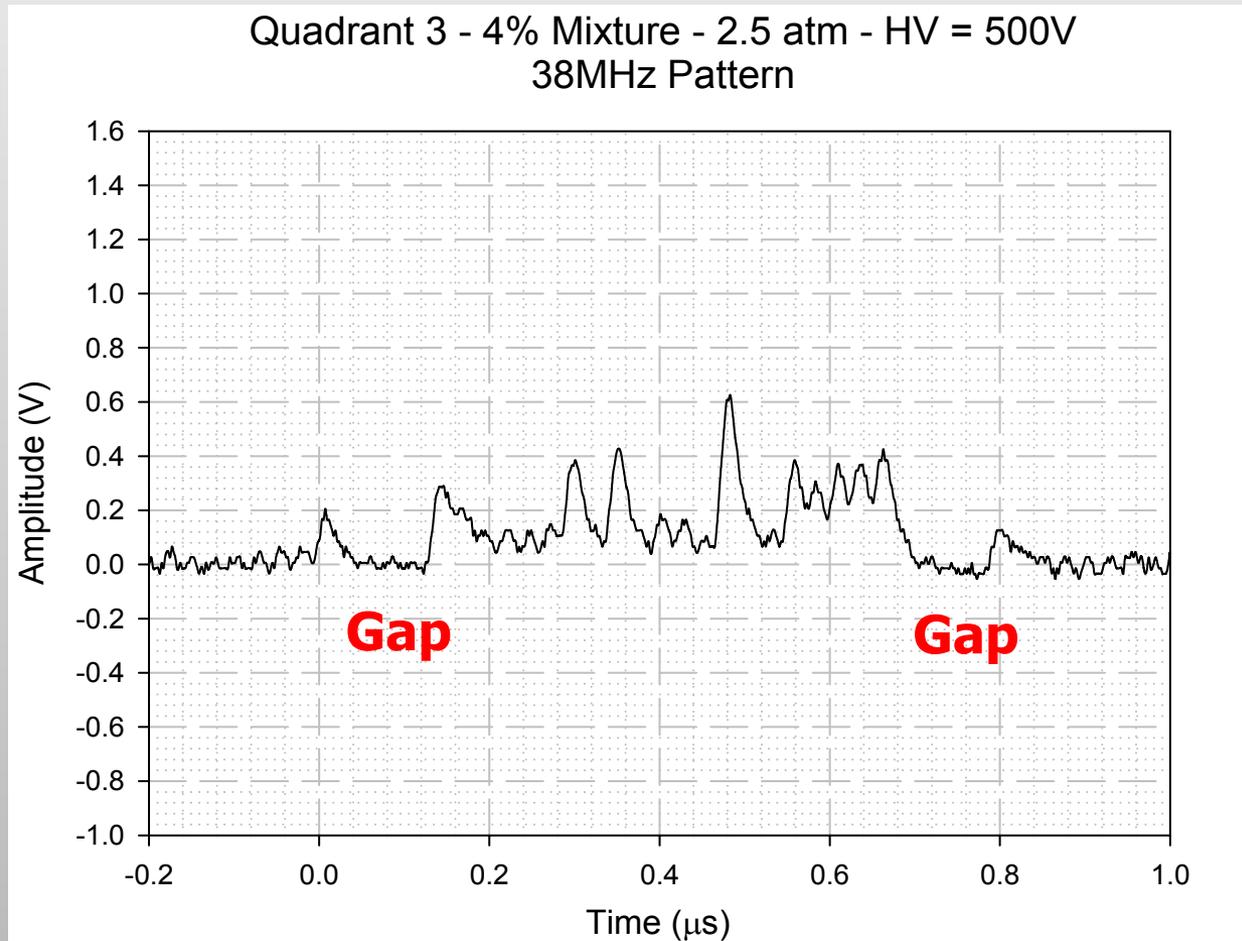
# 19 MHz

- Fill pattern = 11 bunches – 52 ns between bunches
- 84 ns gaps



# 38 MHz

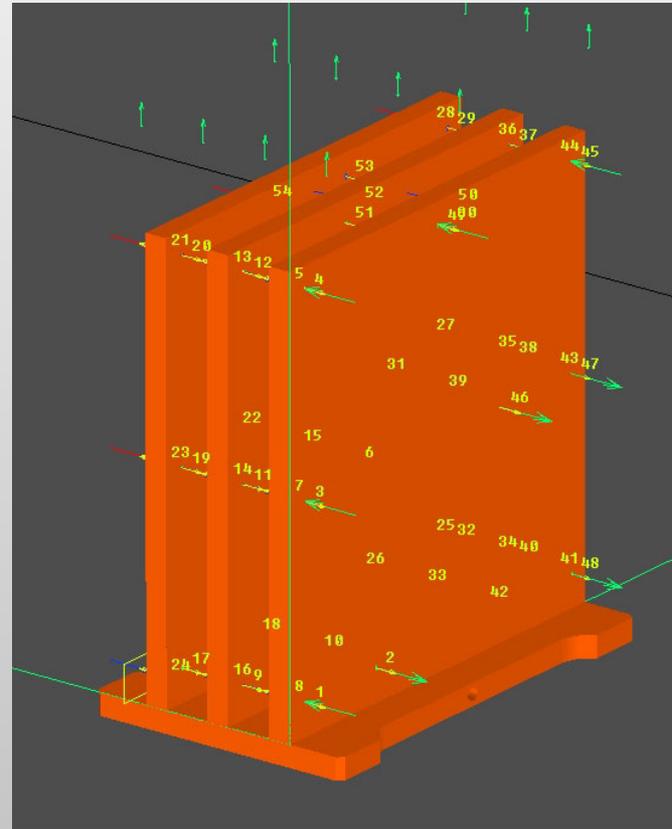
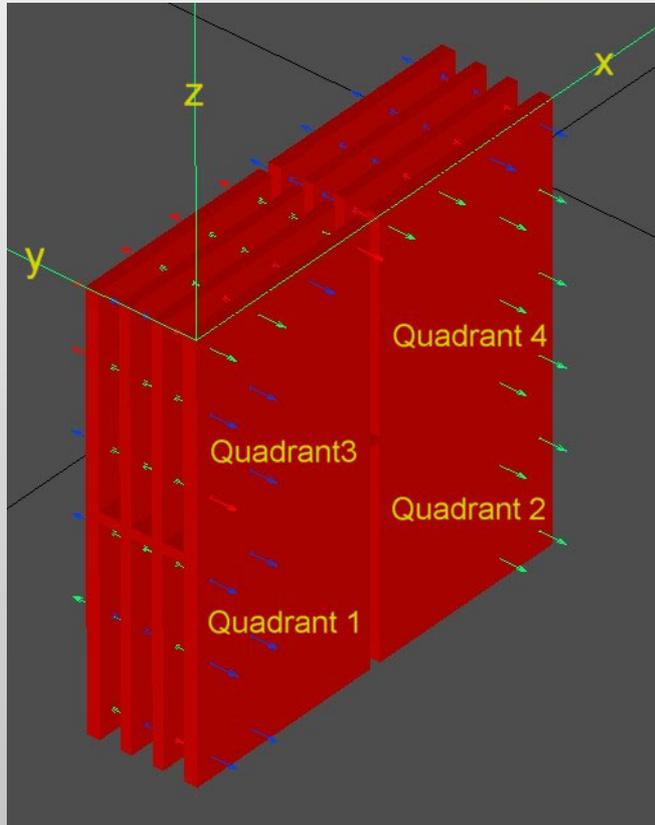
- Fill pattern = 22 bunches – 26 ns between bunches
- 84 ns gaps



# Performance Summary and Next Steps

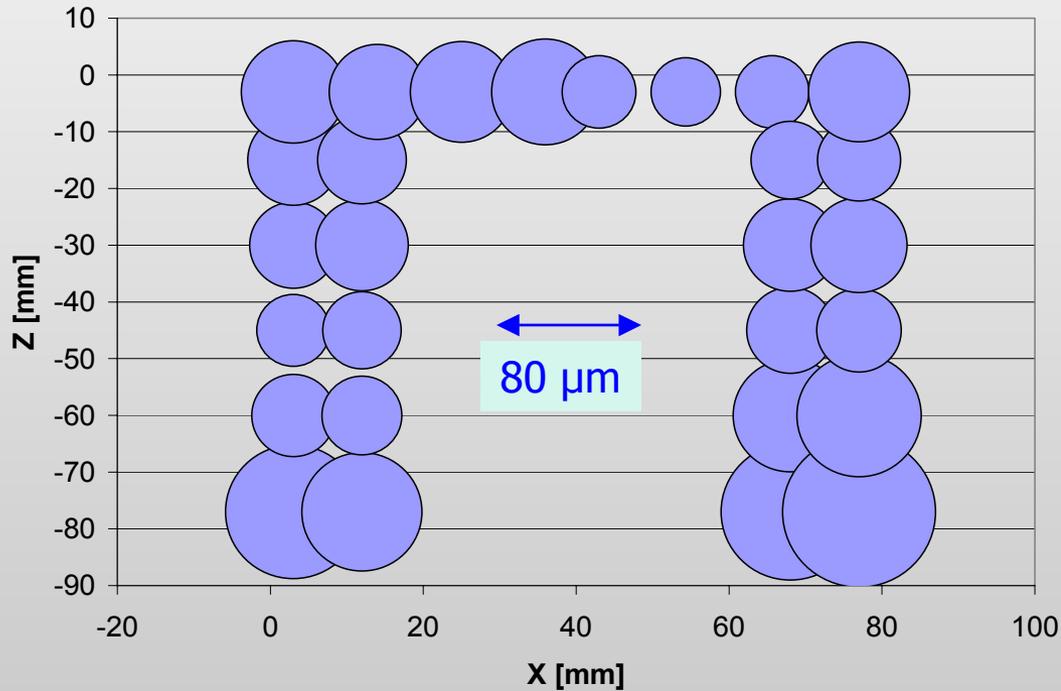
- Chamber + TAN insert designed and built
- Operates as predicted, works as 4-quadrant detector with no cross-talk
- Gas pressure and voltage behavior as simulated
- ALS BTS setup established for precise tests (need DAQ improvement in order to determine ultimate position resolution – currently  $\sim 100 \mu\text{m}$ , but systematics limited)
- ALS ring setup for 40 MHz test
  - Leaky capacitor required removal/repair of chamber late December. Re-install next Tuesday
- Proceed to final mechanical design issues (see next slides)
- Electronics integration
- Intended radiation test at RTF abandoned

# Machining Issues (1)

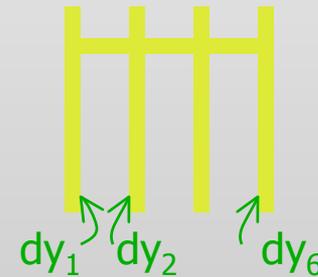


Survey ground plane and each "comb"

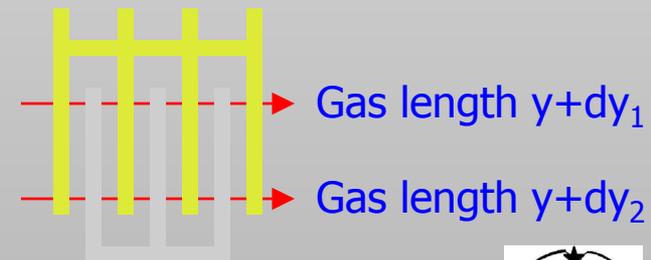
# Machining Issues (2)



Ground plane RMS vs position. Avg=35 μm

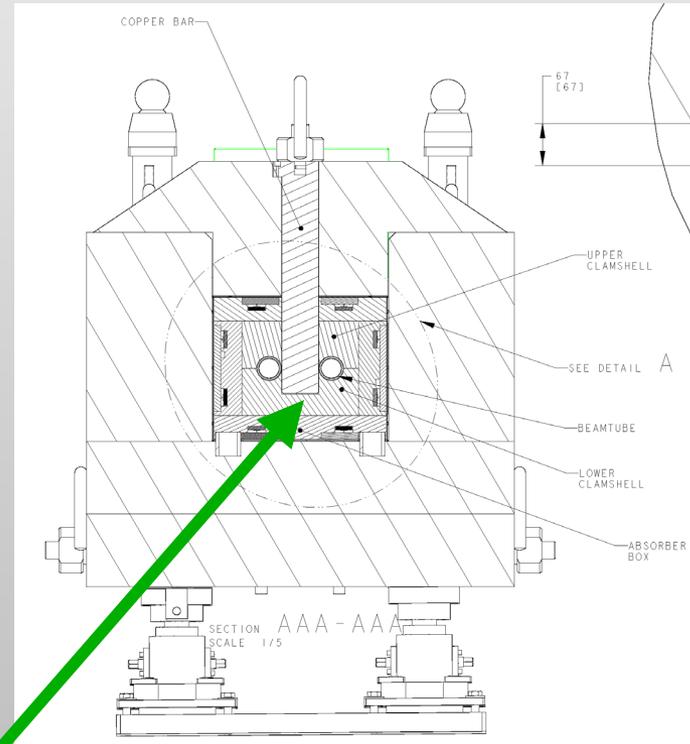
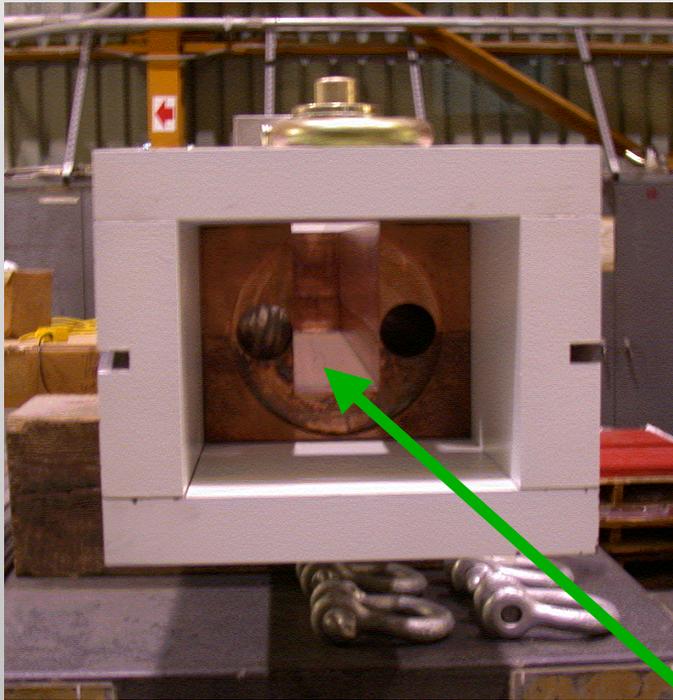


Resolution:  $dy = \text{const.}$  (indep. of  $x, z$ )



# Need to Design Manipulator

- Shielded manipulator for removing TAN insert



Instrumentation slot

# Proposed Test at FNAL RTF

>100 MGy/year (>0.1 TRad for 10 year operation)

